

VDS	RDS(on)	ID@25℃		
1700V	1000mΩ	5A		

### **Applications:**

- Solar Inverters
- Switch Mode Power Supplies
- High Voltage DC/DC Converters
- EV Charging
- Motor Drives

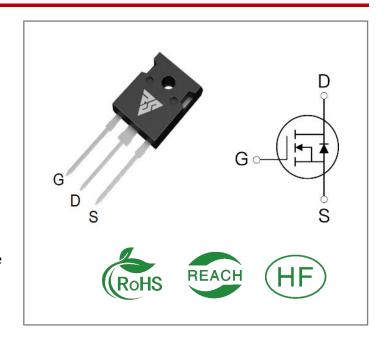
#### **Features:**

- High Blocking Voltage with Low On-Resistance
- High Speed Switching with Low Capacitances
- Easy to Parallel and Simple to Drive
- Avalanche Ruggedness

#### **Benefits:**

- Higher System Efficiency
- Reduced Cooling Requirements
- Increased Power Density
- Increased System Switching Frequency

### **Ordering Information**



Part Number	Package	Marking	Packing	Qty.
RSM1701K0W	TO-247-3	RSM1701K0W	Tube	30 PCS

### Maximum Ratings (TJ= 25℃ unless otherwise specified)

Symbol	Parameter	Value	Unit	Test Conditions	Note
VDSmax	Drain - Source Voltage	1700	<b>V</b>	VGS=0V,ID =100μA	
VGSmax	Gate - Source Voltage	-10/+2 5	٧	Absolute maximum values	
VGSop	Gate - Source Voltage	-5/+20	V	Recommended operational values	
ID	Continuous Drain Current	5 3.5	А	VGS=20V, TC =25 °C VGS=20V, TC =100 °C	
ID(pulse)	Pulsed Drain Current	6	А	Pulse width tp limited by TJmax	
PD	Power Dissipation	69	W	TC =25℃, TJ =150℃	
TL	Solder Temperature	260	$^{\circ}$		
TJ, Tstg	Operating Junction and StorageTemperature	-40 to + 150	$^{\circ}$		



# **Electrical Characteristics** (TJ= 25°C unless otherwise specified)

Symbol	Parameter	Min.	Тур.	Max	Unit	Test Conditions	Note
V(BR)D SS	Drain-Source Breakdown Voltage	1700			V	VGS=0V,ID =100μA	
) (OS/II )	Gate Threshold	2.5	3.0	4.5	V	VGS= VDS, IDS=1mA,TC =25°C	
VGS(th)	Voltage		2.2		٧	VGS= VDS, IDS=1mA,TC =150°C	
IDSS	Zero Gate Voltage Drain Current		1	100	μΑ	VDS= 1700V, VGS=0V	
IGSS	Gate-Source Leakage Current			250	nA	VGS=25V, VDS= 0V	
RDS(on)	Drain-Source on-state		1000	1300	mΩ	VGS=20V, ID =2A, TC =25℃	
KD3(011)	Resistance		1500			VGS=20V, ID =2A, TC =150°C	
Ciss	Input Capacitance		186			VGS=0V, VDS=1000 V,	
Coss	Output Capacitance		12		pF	f=1MHz, VAC=25 mV	
Crss	Reverse Transfer Capacitance		1.6			•	
EON	Turn-On Switching Energy		48		μJ	VDS =1200V, VGS =-5/20V,ID = 2A,	
EOFF	Turn-Off Energy		18		μ	RG(ext) = 2.5Ω, L= 1500μH	
td(on)	Turn-On Delay Time		5.2				
tr	Rise Time		9.4		ns	VDS =1200V, VGS =-5/20 V ID = 2A, RG(ext) =2. 5 Ω,	
td(off)	Turn-Off Delay Time		13.2		115	$RL = 600\Omega$	
tf	Fall Time		22				
RG(int)	Internal Gate Resistance		22		Ω	Ω f=1 MHz, VAC=25mV	
Qgs	Gate to Source Charge		5.2		nC		
Qgd	Gate to Drain Charge		7.3		nC VDS=1200V, VGS=-5/20V ID =2A		
Qg	Total Gate Charge		21.8				



# Reverse Diode Characteristics (TJ= 25°C unless otherwise specified)

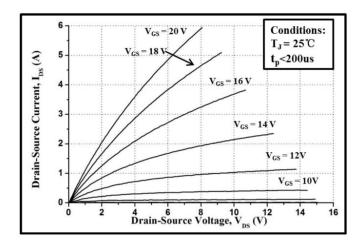
Symbol	Parameter	Тур.	Max	Unit	Test Conditions	Not e
VSD	Diodo Forward Voltago	4.2		V	VGS=-5V, ISD = 1 A, TJ = 25°C	
VSD Diode Forward Voltage		3.9		V	VGS=-5V, ISD= 1 A, TJ= 150℃	
IS	Continuous Diode Forward Current		4	Α	VGS=-5V,TC= 25 °C	
trr	Reverse Recovery time	25		ns		
Qrr	Reverse Recovery Charge	15		nC	ISD= 2 A, VR = 1200V	
Irrm	Peak Reverse Recovery Current	2.8		Α		

### Thermal Characteristics (TJ= 25°C unless otherwise specified)

Symbol	Parameter		Unit	Test Conditions	Not e
RθJC	Thermal Resistance from Junction to Case	1.8	°C/W		
RθJA	Thermal Resistance From Junction to Ambient	40	C/ <b>VV</b>		



#### **Typical Feature Curve**



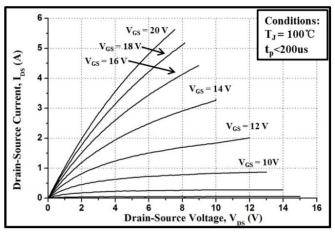
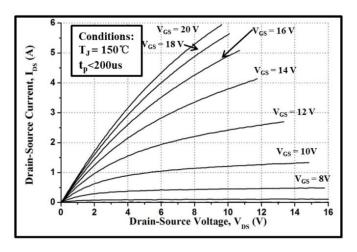


Figure 1. Typical Output Characteristics T<sub>J</sub>= 25°C





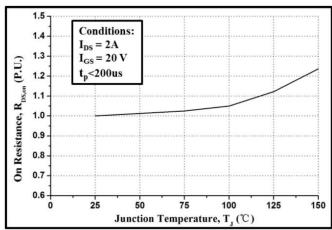
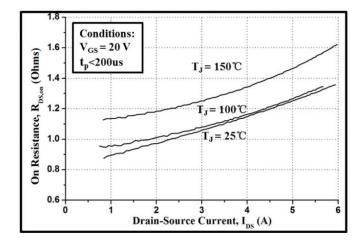


Figure 3. Typical Output Characteristics T<sub>J</sub>=150°C

Figure 4. Normalized On-Resistance vs. Temperature



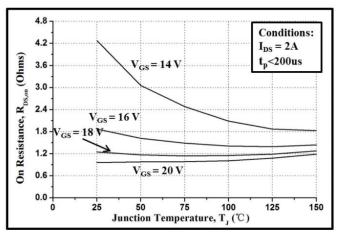
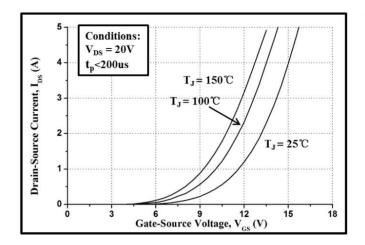


Figure 5. On-Resistance vs. Drain Current

Figure 6. On-Resistance vs. Temperature

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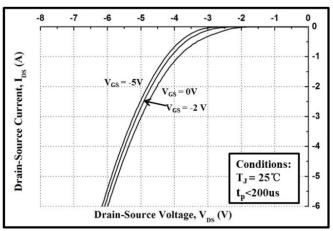
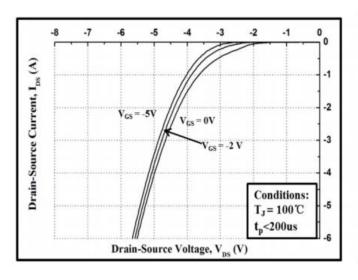


Figure 7. Typical Transfer Characteristics

Figure 8. Body Diode Characteristics at 25°C



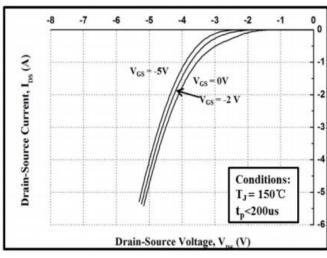
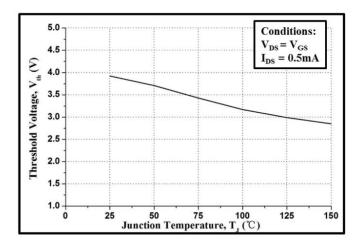


Figure 9. Body Diode Characteristics at 100°C

Figure 10. Body Diode Characteristics at 150°C



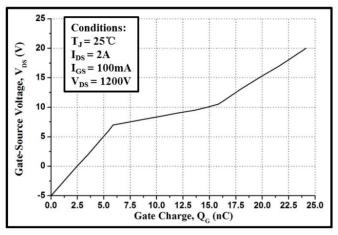
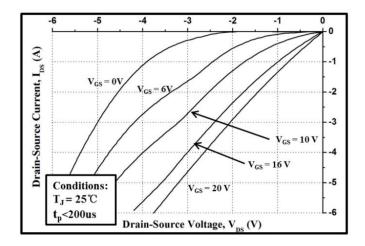


Figure 11. Gate Threshold Voltage vs. Temperature

Figure 12. Gate Charge Characteristic

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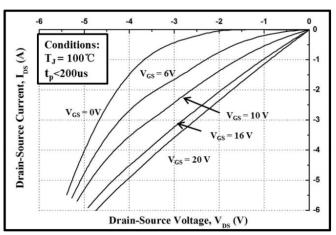
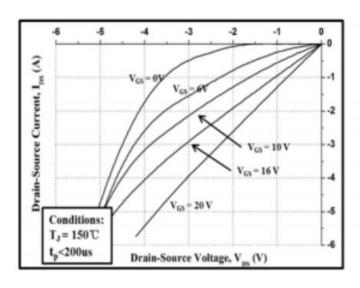


Figure 13. 3rd Quadrant Characteristics at 25°C

Figure 14. 3rd Quadrant Characteristics at 100°C



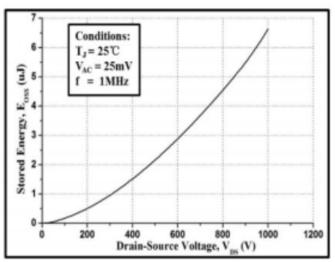
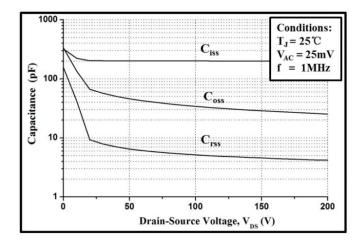


Figure 15. 3rd Quadrant Characteristics at 150°C

Figure 16. Output Capacitor Stored Energy



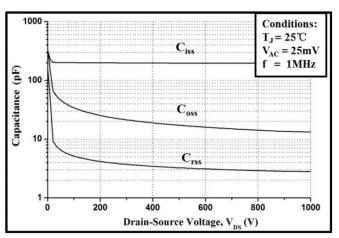


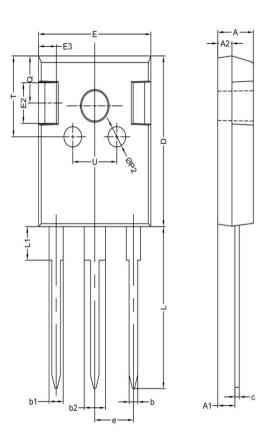
Figure 17. Capactances vs. Drain-Source Voltage

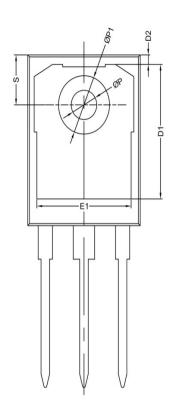
Figure 18. Capactances vs. Drain-Source Voltage

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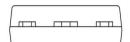


# Package outline drawing(TO-247-3 Unit: mm)





W []		机械尺寸/mr	n
符号	最小值	典型值	最大值
Α	4.80	5.00	5.20
A1	2.21	2.41	2.61
A2	1.90	2.00	2.10
b	1.10	1.20	1.35
b1		2.00	
b2		3.00	
С	0.55	0.60	0.75
D	20.80	21.00	21.20
D1		16.55	
D2		1.20	
E	15.60	15.80	16.0
E1		13.30	
E2		5.00	
E3		2.50	
е		5.44	
L	19.42	19.92	20.42
L1		4.13	
Р	3.50	3.60	3.70
P1	-	-	7.40
P2		2.50	
Q		5.80	
S	6.05	6.15	6.25
Т		10.00	
U		6.20	





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